Lecture 11 -Optical Sources and Transmitters

	Table 1 - MSA Standards Overview			
	- Jos A	Synopsis		
	rs			
	5	"Small Form Factor Pluggable"		
		popular mainstream pluggable for data rates to 2.5 Gb/s, up to 4 Gb/s Fiber		
		Channel		
		SFP+ being promoted for 10 Gb/s		
		DWDM versions avail able for Metro telecom systems		
		www.sffcommittee.org		
	XFP	"10G Small Form Factor Pluggable"		
		10GbEthemet, OC192,		
		(10G FC anticipated)		
		Available in non -WDM, CWDM and DWDM versions		
		Available to 80 km reach		
		Nana Appres on		
	10 Ghit Ethernet Ti			
	Vannak	VALU alastrias interface		
	лепрак	Hot nluggable		
		Large legacy market		
		www.xenpak.org		
	Xpak/X2	Functionally equivalent to Xenpak, but XPAK and X2 are two rival mechanical		
		designs in a smaller form factor. Designs do not require card cutout.		
	Other Selected Tra	www.x2msa.org www.xpak.org		
	200nin	Fixed bluggshle transponder		
	500pm	SFF (Small Form Factor) version more space efficient		
		Large nower dissination budget allows advanced (high power) functions to be		
		implemented		
		10GbE and OC192 Sonet/SDH		
		Tunable Laser versions available.		
	Parallel Ontics	www.300pinmsa.org		
		12 sharped and 4 sharped normalial antice machiles for your short much ultre high		
	SNAF12, FOF4, Quadlink	12 channel and 4 channel parallel optics modules for very short reach, una high bandwidth applications		
	Quaannik	bandwidth approactions.		
	and the second second	www.snapoptics.org		
	Constitution			
ECE 228A Fall 2008 I		www.popopucs.org nal	11.2	
202 220111 011 2000 1				

Photon Energy and Bandgap

Energy of Photon

$$E_a - E_b = \hbar\omega = E_g + \frac{\hbar^2 k^2}{2m_c} + \frac{\hbar^2 k^2}{2m_v}$$

For an electron in upper state a and potential lower state b, the downward rate of transition is

$$R_{a \to b} \propto f_c(E_a) \left[1 - f_v(E_b) \right]$$

Effective inversion due to electrons and holes within dk



$$\begin{split} N_2 - N_1 &\rightarrow \frac{\rho(k)dk}{V} \Big\{ f_c(E_a) \Big[1 - f_v(E_b) \Big] - f_v(E_b) \Big[1 - f_c(E_a) \Big] \Big\} \\ &= \frac{\rho(k)dk}{V} \Big[f_c(E_a) - f_v(E_b) \Big] \end{split}$$





•Light is emitted from forward biased junction in all directions

LED Optical Characteristics

1

Internal optical power \Rightarrow

⇒ Output optical Power

$$P_{\text{int}} = \left(\eta_{\text{int}} \frac{I}{q}\right)(\mathsf{h}\omega) = \left(\frac{\# \text{ photons}}{\text{sec}}\right) \left(\frac{\text{energy}}{\text{photon}}\right)$$
$$P_{\text{out}} = \eta_{\text{ext}} P_{\text{int}} = \eta_{\text{ext}} \cdot \eta_{\text{int}} \frac{I}{q} \hbar \omega$$
$$\text{Internal quantum efficiency}$$

Output coupling efficiency

⇒ Important: the output optical power is (to a first instance) proportional to the driving current:

$$P_{\rm out}(t) \cong k \cdot I(t)$$

LED Spectral Width

⇒ Full width half maximum spectral width: it is roughly given by: $\Delta v \approx 1.8 K_B T/_b$

$$\Delta \lambda \approx 1.8 K_B T \frac{\lambda^2}{ch}$$

 \Rightarrow Note that it is directly proportional to the device temperature *T*



Ex : GaAs LEDs (830 nm, 300 K) $\Rightarrow \Delta \lambda \approx 30 \text{ nm}$

InGaAsP LEDs (1310 nm, 300 K) $\Rightarrow \Delta \lambda \approx 60 \text{ nm}$

 \Rightarrow The output optical power (coupled in the output fiber pigtail) for most commercial LED is in the order of

-20 dBm to -10 dBm

LED Modulation Bandwidth

The average time it takes for an electron to arrive in the active region due to I_{bias} and for an electron to disappear from the active region due spontaneous recombination is called the carrier lifetime (τ_c)



Example: τ_c is on the order of 1-5ns. Therefore the electrical bandwidth is on the order of

Important Laser Diode Parameters

- ⇒ Light current curve:
 - \Rightarrow Threshold current (typically I_{th}=1-20 mA)
 - \Rightarrow Temperature dependence of threshold (T₀=100K)
 - \Rightarrow Slope efficiency (typically R=0.2 mW/mA)
 - ⇒ Quantum efficiency (fraction of input electrons that produce useful light) η =R e/hv=R/(1.24W/A/\lambda)
- ⇒ Near field and far field characteristics
 - \Rightarrow Fiber coupling
- ⇒ Spectra
 - \Rightarrow Dispersion

Lasing Threshold

⇒ Power-Current (P-I) Characteristics





Fig. 5.25 L-I characteristics of a 1.3-µm InGaAsP DCPBH laser at different temperatures.

Spectra

The spectra is current dependent. As you modulate from off to on, the spectra changes.

For long distance, single mode is essential, and what matters is single mode under modulation



p248

ECE 228A Fall 2008 Daniel J. Blumenthal

Fig. 6.6 Longitudinal-mode spectra of a gain-guided laser observed at several power levels. Experimental spectra for an index-guided laser are shown in Fig. 2.12. (After Ref. 35)

Semiconductor Emission Wavelength

- \Rightarrow Emission wavelength depends on the bandgap energy (E_g) of semiconductor material
- Direct bandgap semiconductors are more efficient for light generation than indirect bandgap semiconductors (e.g., silicon)

AlGaAs	InGaAsP
.8187 μm	1.0 - 1.65 μm

Double Heterostructure Lasers (Kroemer)

- ⇒ Carriers diffuse away so it is difficult to get high gain
- \Rightarrow A method of confining the carriers to a region in space is necessary
- ⇒ Double heterostructure (proposed in 1964 but not implemented until 1968, which led to the first cw lasers).



Optical and quantum confinement

 \Rightarrow A heterostructure is a p-n junction between materials with dissimilar bandgaps

 \Rightarrow Used to confine: Carriers (efficiency) and Photons (waveguide)





⇒ The equivalent of an electronic comb filter, but for optical frequencies, the Fabry-Perot (FP) cavity is used for feedback in lasers and as optical filters



Multimode Fabry-Perot SC Lasers



FP SC Laser Output Characteristics



•1.3 μ m multimode lasers are good for bit rates < 2Gbs and distances up to 100 km.

Carrier Density Modulation

⇒ Plotting the magnitude change in n_1 as a function of ω_m , we see the relaxation oscillation frequency introduced in the last lecture.

$$n_1(\omega_m) = -i\left(\frac{i_1}{Vq}\right) \frac{\omega_m}{\omega_m^2 - \frac{AP_0}{\tau_p} - i\omega_m\left(\frac{1}{\tau} + AP_0\right)} \qquad \qquad \omega_R = -i\omega_m\left(\frac{1}{\tau} + AP_0\right)$$

$$\rho_R = \sqrt{\frac{AP_0}{\tau_p} - \frac{1}{2} \left(\frac{1}{\tau} + AP_0\right)^2}$$



Rate Equations

Neglecting the phase of the optical field, the length dependence of the carrier and photon densities, and the modal dependence; the rate equations for the averaged photon and carrier densities become:

$$\frac{dS}{dt} = \frac{\Gamma v_g a \left(N - N_{tr}\right)}{1 + \varepsilon S} S - \frac{S}{\tau_p} + \frac{\beta \Gamma N}{\tau_n}$$
$$\frac{dN}{dt} = \eta_i \frac{I}{qV} - \frac{v_g a \left(N - N_{tr}\right)}{1 + \varepsilon S} S - \frac{N}{\tau_n}$$

Gain Suppression (Non-Linear Gain)

- \Rightarrow Previously we talked about different effects that reduce the overall material gain.
- ⇒ Yariv and Yeh differentiate between the following
 - \Rightarrow Gain Saturation: Drop in gain population N due to increase in photon density
 - ⇒ Gain Supression: Total carrier density N is constant but distribution of carriers as a function of energy or momentum changes with photon density. Former is called Dynamic Carrier Heating (DCH) and the later Spectral Hole Burning (SHB).
- ⇒ Rewriting the optical gain constant to include the *gain supression factor* ε by performing a Taylor Series Expansion about (N=N_{th}, P₀)

$$G(N,P) = G(N)(1 - \varepsilon P) \approx G(N_{th}) + A(N - N_{th}) - \varepsilon G(N_{th})P$$

Gain Suppression

⇒ Re-writing the small signal photon density modulation term to include gain suppression

$$p_1(\omega_m) = \frac{-\Gamma_a A P_0\left(\frac{i_1}{Vq}\right)}{\omega_m^2 - i\omega_m \left(\frac{1}{\tau} + A P_0 + \frac{\varepsilon P_0}{\tau_p}\right) - \left(\frac{A P_0}{\tau_p} + \frac{\varepsilon P_0}{\tau\tau_p}\right)}$$

 \Rightarrow Example:

$$P_{0} = 1.2 \times 10^{21} \text{ photons/m}^{3}$$

$$A = 2 \times 10^{-12} \text{ m}^{3}/\text{s}$$

$$\tau_{p} = 10^{-12} \text{ s}$$

$$\tau = 10^{-9} \text{ s}$$

$$\varepsilon = 10^{-23} \text{ m}^{3}$$

$$\frac{\varepsilon P_{0}}{\tau_{p}} = 1.2 \times 10^{10} \text{ s}^{-1} \text{ A}P_{0}$$

- ⇒ Under the operating condition that $\varepsilon P_0 / \tau_p >> AP_0$ $\omega_R \approx \sqrt{\frac{AP_0}{\tau_p} - \frac{\varepsilon^2 P_0^2}{2\tau_p^2}}$
- \Rightarrow So considering gain suppression, P₀ and ω_R reach maximum values at

$$(P_0)_{\max} = \frac{A\tau_p}{\varepsilon^2}$$
$$(\omega_R)_{\max} = \frac{A}{\sqrt{2}\varepsilon}$$

 \Rightarrow Using the values from the previous example

$$(P_0)_{\text{max}} = 2 \times 10^{22} \text{ photons/m}^3$$

 $(f_R)_{\text{max}} = \left(\frac{\omega_R}{2\pi}\right)_{\text{max}} = 2.24 \times 10^{10} \text{ Hz}$

GaAs/GaAlAs and GaInAsP Lasers

\Rightarrow GaAs/ Ga_{1-x}Al_xAs Lasers

- \Rightarrow Active region (gain) is either GaAs or Ga_{1-x}Al_xAs.
- ⇒ AlAs has a larger bandgap than GaAs
 - \Rightarrow Therefore Ga_{1-x}Al_xAs has a bandgap in between
- ⇒ X indicates fraction of Ga atoms in GaAs
- ⇒ Light frequency emission depends on active region x and its doping
 - \Rightarrow 0.75 $\mu m < \lambda < 0.88 \ \mu m$

\Rightarrow Ga_{1-x}In_xAl_{1-y}P_yLasers

- \Rightarrow Active region is Ga_{1-x}In_xAl_{1-y}P_y
- \Rightarrow Light frequency emission depends on active region x and y and its doping
 - \Rightarrow 1.1 µm < λ < 1.6 µm

GaAs/Ga_{1-x}Al_xAs Double Heterostructure Lasers

- ⇒ Three layered dielectric waveguide
 - ⇒ Thin active layer undoped
 - ⇒ Cladding GaAlAs layers heavily dope p and n
 - ⇒ Index contrast approximately given by
 - \Rightarrow $n_{GaAs} n_{Ga_{1-x}Al_xAs} \cong 0.62x$
- \Rightarrow Under positive bias
 - \Rightarrow e⁻ injected into active region from n-side and h⁺ from p-side
 - ⇒ Injected electrons prevented from diffusing out of active region due to ΔE_c . Injected holes prevented from diffusing out of active region due to ΔE_v .
 - $\Rightarrow \Delta E_c \approx 0.6E_g; \Delta E_v \approx 0.4E_g$
- Double confinement of injected carriers and optical mode to the same active region.



Modal Gain

⇒ When the gain coefficient γ is constant over active region width, the *modal gain* can be defined as

$$g = \gamma \Gamma_{a} - \alpha_{n} \Gamma_{n} - \alpha_{p} \Gamma_{p}$$

$$\Gamma_{a} = \frac{\int_{-\frac{d}{2}}^{\frac{d}{2}} |E|^{2} dz}{\int_{-\frac{d}{2}}^{\infty} |E|^{2} dz}; \Gamma_{n} = \frac{\int_{-\infty}^{-\frac{d}{2}} |E|^{2} dz}{\int_{-\infty}^{\infty} |E|^{2} dz}; \Gamma_{p} = \frac{\int_{\frac{d}{2}}^{\infty} |E|^{2} dz}{\int_{-\infty}^{\infty} |E|^{2} dz}; \Gamma_{p} = \frac{\int_{-\frac{d}{2}}^{\infty} |E|^{2} dz}; \Gamma_{p} = \frac{\int_{-\frac{d}{2}}^{\infty} |E|^{2} dz}{\int_{-\infty}^{\infty} |E|^{2} dz}; \Gamma_{p} = \frac{\int_{-\frac{d}{2}}^{\infty} |E|^{2} dz}{\int_{-\infty}^{\infty} |E|^{2} dz}; \Gamma_{p} = \frac{\int_{-\frac{d}{2}}^{\infty} |E|^{2} dz}{\int_{-\infty}^{\infty} |E|^{2} dz}; \Gamma_{p} = \frac{\int_{-\frac{d}{2}}^{\infty} |E|^{2} dz}; \Gamma_{p} = \frac{\int_{-\frac{d}{2}}^{\infty} |E|^{2} dz}{\int_{-\infty}^{\infty} |E|^{2} dz}; \Gamma_{p} = \frac{\int_{-\frac{d}{2}}^{\infty} |E|^{2$$

- \Rightarrow α_n is the loss in un-pumped n-type GaAlAs and α_p loss hat pumped ptype GaAlAs. γ is gain in pumped active layer. Γ_a , Γ_n , Γ_p are the fraction of optical mode power in the active region, n-type and p-type cladding regions respectively.
- ⇒ Varying d changes the mode shape and relative confinement to the active and surrounding cladding regions as shown by example on the right.
- The mode shape we are talking about here is the gain guided (vertical) mode shape. The mode lateral confinement will be discussed a little later in the lecture.



Yariv and Yeh, Photonics

Threshold Current Density

- As d decreases, Γ_a decreases, and more mode power propagates outside the active region and does not receiver gain and can be attenuated.
- ⇒ Threshold gain condition can be written as

$$\gamma \Gamma_a = \alpha_n \Gamma_n + \alpha_p \Gamma_p - \frac{1}{L} \ln R + \alpha_s$$

- Given losses, R and confinement factors, we can calculate the gain γ required for threshold.
- Under steady state, the carrier injection rate equals the electron-hole recombination rate, and the electron hole recombination rate can be calculated for the required γ

$$\frac{J}{q} = \frac{Nd}{\tau}$$
$$\frac{J}{d} = \frac{Nq}{\tau}$$
$$\frac{J_{th}}{d} = \frac{N_{th}q}{\tau}$$

⇒ Threshold current density (J_{th}/d) is plotted on the right as a function of active layer thickness for a broad area (low lateral confinement) laser



Yariv and Yeh, Photonics

Power Output

- As the injected current increases beyond threshold, the laser oscillation intensity increases and the stimulated emission dominates the carrier lifetime to the point where the inversion is clamped at its threshold value
- \Rightarrow For η_i defined as the probability that an injected carrier recombines radiatively in the active region, the power emitted via stimulated emission is (we derived this previously for steady state)
- \Rightarrow The total stimulated radiation is either absorbed in the cavity or eventually escapes out of the laser cavity as output power.

$$P_e = \frac{(I - I_{th})\eta_i}{q}hv$$

$$P_o = \frac{(I - I_{th})\eta_i}{q} hv \frac{\left(\frac{1}{L}\right) \ln\left(\frac{1}{R}\right)}{\alpha + \left(\frac{1}{L}\right) \ln\left(\frac{1}{R}\right)}$$

Differential Quantum Efficiency

- ⇒ The ratio of the photon output rate resulting from a given input carrier injection rate is the external differential quantum efficiency η_{ex}
- ⇒ And the overall laser efficiency is $\eta_{ex} = \frac{d(P_O / hv)}{d[(I I_{th}) / q]}$

$$\eta_{ex} = \frac{P_O}{IV_{appl}} = \eta_i \frac{I - I_{th}}{I} \frac{h\nu}{qV_{appl}} \frac{\ln\left(\frac{1}{R}\right)}{\alpha L + \ln\left(\frac{1}{R}\right)}$$